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| Form 1449 (Modified) Information Disclosure Statement By Applicant (Use Several Sheets if Necessary) | Atty Docket No. | ODVFP008 |
| | Application No.: | 10/849,602 |
| | Applicant | Reese, David Byrne |
| | Filing Date | May 19, 2004 |
| | Group | 2454 |
| | | Page 1 of 1 |
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| Examiner Initial | No. | Patent No. | Date | Patentee | Class | Sub-class | Filing Date |
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Foreign Patent or Published Foreign Patent Application

| Examiner Initial | | Document No. | Publication Date | Country or Patent Office | Class | Sub-Class | Translation | |
|------------------|--|--------------|------------------|--------------------------|-------|-----------|-------------|----|
| | | | | | | | Yes | No |
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Other Documents

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| | 9. | US Office Action dated 8/31/09 issued in 11/021,716 |
| | 10. | US Examiner Interview Summary dated 12/2/09 issued in 11/021,716 |
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| | 13. | US Office Action Final dated 12/8/09 issued in 11/014,149 |
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| Examiner | Date Considered |
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Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.